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March 2015



30V N-Channel PowerTrench^o MOSFET

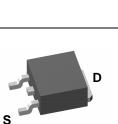
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on state resistance and yet maintain low gate charge for superior switching performance.

G

Applications

- DC/DC converter
- Motor Drives

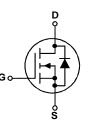


Features

• 46 A, 30 V
$$R_{DS(ON)} = 12 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$$

 $R_{DS(ON)} = 14 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$

- Low gate charge
- Fast Switching Speed
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$



Absolute Maximum Ratings TA=25°C unless otherwise noted

D-PAK (TO-252)

Symbol	Para	meter		Ratings	Units
V _{DSS}	Drain-Source Voltage			30	V
V _{GSS}	Gate-Source Voltage			±20	V
ID	Continuous Drain Current	@T _c =25°C	(Note 3)	46	А
		@T _A =25°C	(Note 1a)	12	
		Pulsed	(Note 1a)	100	
PD	Power Dissipation	@T _c =25°C	(Note 3)	56	W
		@T _A =25°C	(Note 1a)	3.3	
		@T _A =25°C	(Note 1b)	1.5	
T _J , T _{STG}	Operating and Storage Ju	nction Tempera	ture Range	-55 to +175	°C
Therma	Characteristics				·

$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	2.7	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	45	
$R_{ extsf{ heta}JA}$		(Note 1b)	96	

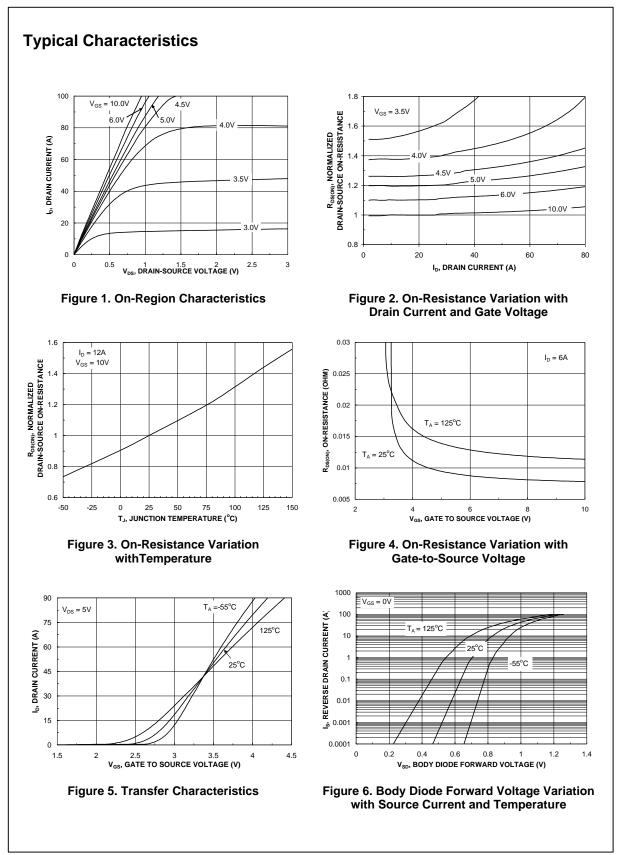
Package Marking and Ordering Information

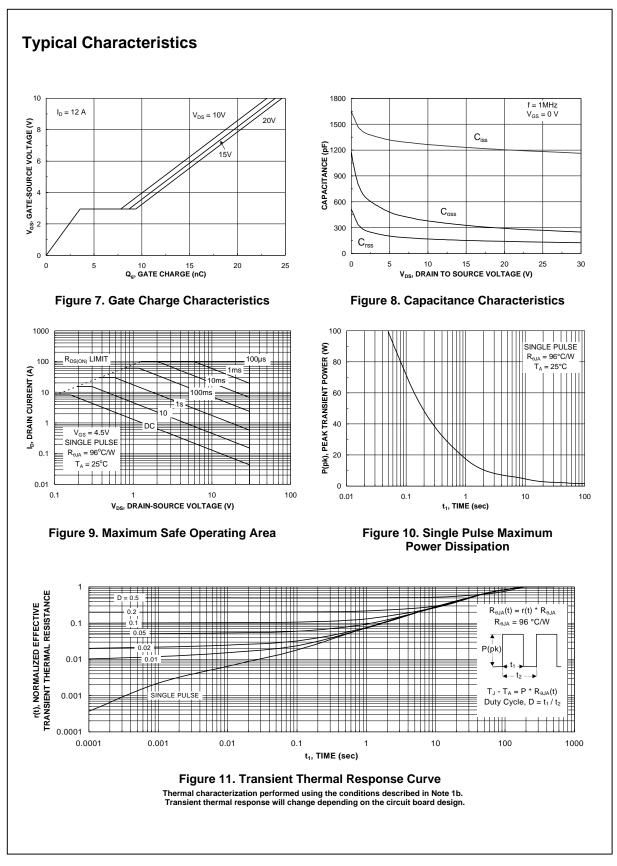
_	Device Marking	Device	Package	Reel Size	Tape width	Quantity
	FDD6690A	FDD6690A	D-PAK (TO-252)	13"	16mm	2500 units
-		•	•			

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-So	ource Avalanche Ratings (Note	2)	•		•	
E _{AS}	Drain-Source Avalanche Energy	Single Pulse, $V_{DD} = 15 \text{ V}$, $I_D = 12 \text{ A}$			180	mJ
I _{AS}	Drain-Source Avalanche Current				12	А
Off Char	acteristics	·		•	•	
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$, $I_{D} = 250 \mu A$	30			V
ΔBV_{DSS} ΔT_J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A,Referenced to 25°C		24		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
On Char	acteristics (Note 2)	<u>.</u>				
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1	1.9	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A,Referenced to 25°C		-5		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$ \begin{array}{ll} V_{GS} = 10 \ V, & I_D = 12 \ A \\ V_{GS} = 4.5 \ V, & I_D = 10 \ A \\ V_{GS} = 10 \ V, & I_D = 12 \ A, T_J = 125^\circ C \end{array} $		7.7 9.9 11.4	12 14 19	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	50			Α
g _{FS}	Forward Transconductance	$V_{\text{DS}} = 10 \text{ V}, \qquad I_{\text{D}} = 12 \text{ A}$		47		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance			1230		pF
C _{oss}	Output Capacitance	$V_{DS} = 15 V$, $V_{GS} = 0 V$, f = 1.0 MHz		325		pF
C _{rss}	Reverse Transfer Capacitance	T = 1.0 MHZ		150		pF
R _G	Gate Resistance	$V_{GS} = 15 \text{ mV}, f = 1.0 \text{ MHz}$		1.5		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn–On Delay Time			10	19	ns
tr	Turn–On Rise Time	$V_{DD} = 15 V, I_D = 1 A,$		7	13	ns
t _{d(off)}	Turn–Off Delay Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		29	46	ns
t _f	Turn–Off Fall Time			12	21	ns
Qg	Total Gate Charge			13	18	nC
Q _{gs}	Gate-Source Charge	$V_{DS} = 15V,$ $I_D = 12 A,$ $V_{GS} = 5 V$		3.5		nC
Q _{gd}	Gate-Drain Charge	163 - 01		5.1		nC

Drain-Source Diode Characteristics and Maximum Ratings Is Maximum Continuous Drain-Source Diode Forward Vollage V _{GS} = 0 V, I _S = 2.3 A (Note 2) 0.76 1.2 V Up to Diode Reverse Recovery Time Ir = 12 A, de/d, = 100 A/µs 0.76 1.2 V Ir Or, Diode Reverse Recovery Time Ir = 12 A, de/d, = 100 A/µs 0.76 1.2 V Ar, bit de aux on of the function to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the data pins. R _{uce} is guaranteed by design while R _{inck} is determined by the user's board design. Image: Source Diode Reverse Recovery Time Image: Source Diode Reverse Recovery Time Image: Source Diode Reverse Recovery Tharge Image: Source Diode Reverse Recovery Time Image: Source Diode Reverse Recoverse	Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Image: signal system Maximum Continuous Drain–Source Diode Forward Current 2.3 A V_{SD} Drain–Source Diode Forward Voltage $V_{GS} = 0$ V, $I_S = 2.3$ A (Note 2) 0.76 1.2 V V_{rr} Diode Reverse Recovery Time $I_F = 12$ A, $d_{IF}/d_t = 100$ A/µs 24 nS Q_{rr} Diode Reverse Recovery Charge 13 nC othes: R_{aJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{aJC} is guaranteed by design while R_{aCA} is determined by the user's board design. b) $R_{aJA} = 96^{\circ}$ C/W when mounted on a $1in^2$ pad of 2 oz copper b) $R_{aJA} = 96^{\circ}$ C/W when mounted on a minimum pad. Scale 1 : 1 on letter size paper Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0% Maximum current is calculated as: $\sqrt{\frac{P_D}{R_{DS(CN)}}}$	Drain–So	urce Diode Characteristics	and Maximum Ratings			•	
irr Diode Reverse Recovery Time IF = 12 A, diF/dt = 100 A/µs 24 nS Qrr Diode Reverse Recovery Charge 13 nC otes: R _{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R _{0JC} is guaranteed by design while R _{0CA} is determined by the user's board design. b) R _{0JA} = 96°C/W when mounted on a 1in ² pad of 2 oz copper b) R _{0JA} = 96°C/W when mounted on a 1in ² pad of 2 oz copper scale 1 : 1 on letter size paper b) R _{0JA} = 96°C/W when mounted on a minimum pad.						2.3	А
Image: matrix formation of the problem in the second pro	/ _{SD}	Drain-Source Diode Forward Voltag	$V_{GS} = 0 V, I_S = 2.3 A$ (Note 2)		0.76	1.2	V
Ω_{rr} Diode Reverse Recovery Charge 13 nC ttes: R_{0,A} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{0,JC}$ is guaranteed by design while R_{0CA} is determined by the user's board design. b) $R_{0,JA} = 96^{\circ}C/W$ when mounted on a 1 in ⁵ pad of 2 oz copper b) $R_{0,JA} = 96^{\circ}C/W$ when mounted on a minimum pad. Scale 1 : 1 on letter size paper Pulse Test: Pulse Width < 300 µs, Duty Cycle < 2.0%					24		nS
$R_{BJA} \text{ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BJC} \text{ is guaranteed by design while } R_{BCA} \text{ is determined by the user's board design.} a) R_{BJA} = 45^{\circ}\text{C/W} \text{ when mounted on a} a) R_{BJA} = 45^{\circ}\text{C/W} \text{ when mounted on a} a) R_{BJA} = 45^{\circ}\text{C/W} \text{ when mounted on a} a) R_{BJA} = 45^{\circ}\text{C/W} \text{ when mounted on a} a) R_{BJA} = 45^{\circ}\text{C/W} \text{ when mounted on a} b) R_{BJA} = 96^{\circ}\text{C/W} \text{ when mounted} a) R_{BJA} = 45^{\circ}\text{C/W} \text{ when mounted on a} b) R_{BJA} = 96^{\circ}\text{C/W} \text{ when mounted} b) R_{BJA} = 96^{\circ}\text{C/W} \text{ when mounted} case thermal reference is defined as the solder mounting surface of the drain pince of the drai$		Diode Reverse Recovery Charge			13		nC
Scale 1 : 1 on letter size paper Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0% Maximum current is calculated as: $\sqrt{\frac{P_D}{R_{DS(ON)}}}$	R _{0JA} is the sum the drain pins.	R_{BJC} is guaranteed by design while $R_{\theta CA}$ is determ a) $R_{\theta JA} = 45^{\circ}C/W$	ined by the user's board design. when mounted on a	b) R _{θJA}	= 96°C/W	when mour	
• Maximum current is calculated as: $\sqrt{\frac{P_D}{R_{DS(ON)}}}$	Dulao Toot: Dul						
	Pulse Test: Pul						
	. Maximum curr	ent is calculated as: $\sqrt{\frac{P}{R_{DS(ON)}}}$					





FDD6690A Rev. 2.1



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